Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/524,079	Reexamination KIMIZUKA ET AL	
Examiner	Art Unit	
RACHEL KAHN	1796	Page 1 of 1

U.S. PATENT DOCUMENTS

	U.S. I AILEN DOCUMENTO				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,017,390	01-2000	Charych et al.	117/68
*	В	US-6,576,679	06-2003	Kimizuka et al.	516/102
*	С	US-6,210,537	04-2001	Murphy et al.	204/157.15
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-		-	
	Т	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN FATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 94041532 B2	06-1994	Japan	ASAKUMA S et al.	
	0					
	Р					
	Q					
	R					
	s					
	т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	Cheung et al, Molecular Organization and Electrical Properties of Mixed Langmuir-Blodgett Multilayer Thin Films of Polypyrrole, 1990, Conjugated Polymeric Materials, Bredas and Chance (eds), p91-99.		
	v	Kimizuka et al, AFM Observation of Organogel Nanostructures on Graphite in the Gel-Assisted Transfer Technique, Chemistry Letters, 1998, p 967-68.		
	w			
	x			

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.